

Silicon N-Channel Planar Power MOSFET

Description

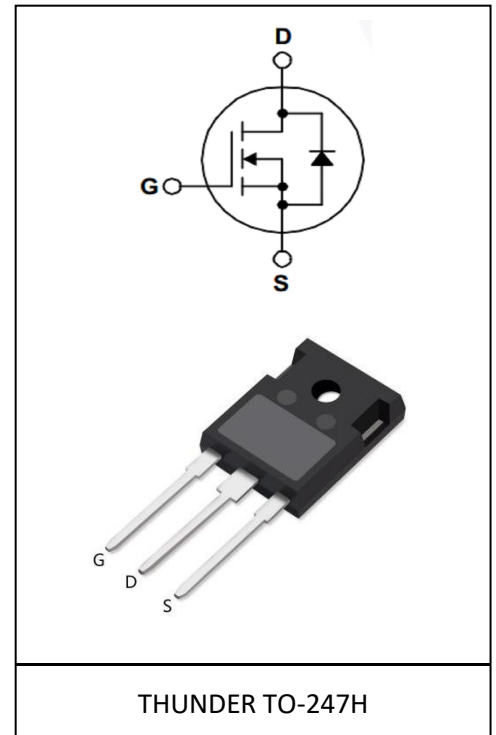
The TH90N30PKH utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this MOSFET are 150°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications. It can be used in a wide variety of applications.

General Features

- $V_{DS}=300V, I_D=90A$
- Low ON Resistance, $R_{DS(ON)}=29m\Omega @ V_{GS}=10V, I_D=45A$
- Low reverse transfer capacitance
- Low Qg for fast response
- Short fall & rise times for fast switching
- 100% single pulse avalanche energy Test

Application

- Power switching application
- Digital amplifier
- Adapter and charger



Product Summary

V_{DS}	300V
$R_{DS(on)}$	29m Ω
I_D	90A

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	300	V
Continuous drain current $T_C = 25^\circ C$ (Silicon limit)	I_D	90	A
Pulsed drain current ($T_C = 25^\circ C$, t_p limited by T_{jmax})	I_{DM}	360	A
Avalanche energy, single pulse ($L=10mH$, $R_g=25\Omega$)	E_{AS}	6792	mJ
Gate-Source voltage	V_{GS}	± 30	V
Power dissipation ($T_C = 25^\circ C$)	P_D	735	W
Operating junction and storage temperature	T_j, T_{stg}	-55...+150	$^\circ C$

Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	0.17	°C/W
Thermal resistance, junction – ambient(min. footprint)	R_{thJA}	40	

Electrical Characteristic (at $T_j = 25\text{ }^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV_{DSS}	300	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate threshold voltage	$V_{GS(th)}$	2.0	-	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Zero gate voltage drain current	I_{DSS}	-	-	1	μA	$V_{DS}=300V, V_{GS}=0V$ $T_j=25^{\circ}\text{C}$
		-	-	10	μA	$V_{DS}=240V, V_{GS}=0V$ $T_j=125^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 30V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	29	35	m Ω	$V_{GS}=10V, I_D=45A$
Transconductance	g_{fs}	-	50	-	S	$V_{DS}=40V, I_D=45A$

Dynamic Characteristic

Input Capacitance	C_{iss}	-	10179	-	pF	$V_{GS}=0V, V_{DS}=25V,$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	1001	-		
Reverse Transfer Capacitance	C_{rss}	-	108	-		
Gate Total Charge	Q_g	-	185	-	nC	$V_{GS}=10V, V_{DS}=240V,$ $I_D=90A$
Gate-Source charge	Q_{gs}	-	40	-		
Gate-Drain charge	Q_{gd}	-	85	-		
Turn-on delay time	$t_{d(on)}$	-	20	-	ns	$V_{DD}=150V, I_D=90A,$ $R_G=25\Omega$
Rise time	t_r	-	28	-		
Turn-off delay time	$t_{d(off)}$	-	95	-		
Fall time	t_f	-	28	-		
Gate resistance	R_G	-	0.37	-	Ω	$V_{GS}=0V, V_{DS}=0V,$ $f=1\text{MHz}$

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	-	1.5	V	$V_{GS}=0V, I_{DS}=90A$
Body Diode Continuous Forward Current	I_S	-	-	90	A	$T_C=25^{\circ}C$
Body Diode Reverse Recovery Time	t_{rr}	-	255	-	ns	$T_C=25^{\circ}C, I_S=90A,$ $di/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{rr}	-	3.3	-	μC	

Typical Performance Characteristics

Fig 1: Output Characteristics

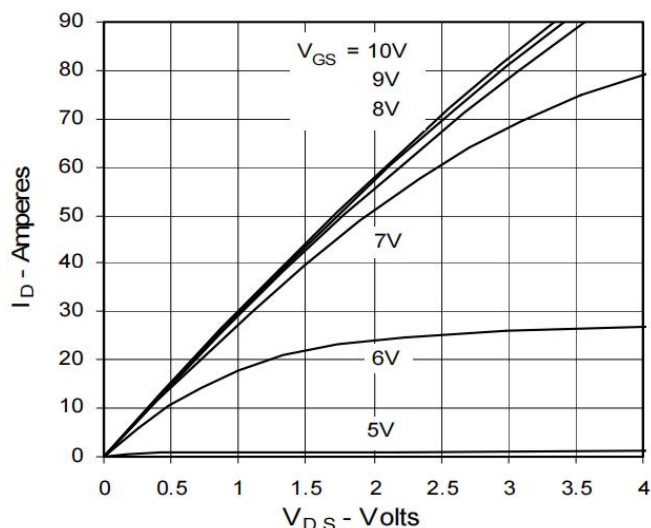


Fig 2: $R_{DS(on)}$ vs. Temperature

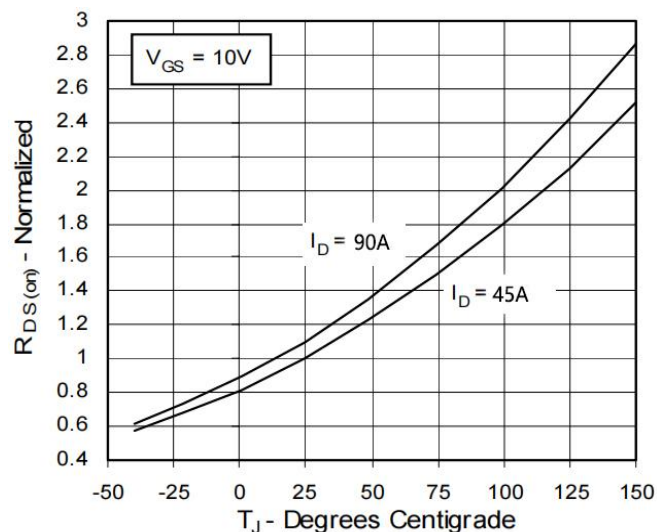


Fig 3: Input Admittance

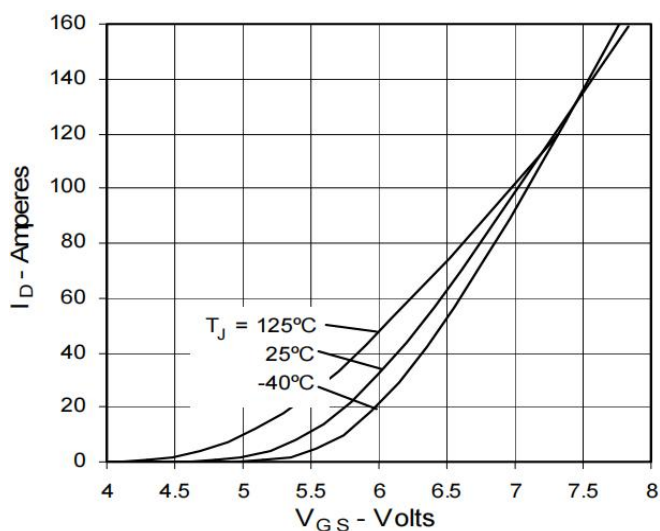


Fig 4: Capacitance Characteristics

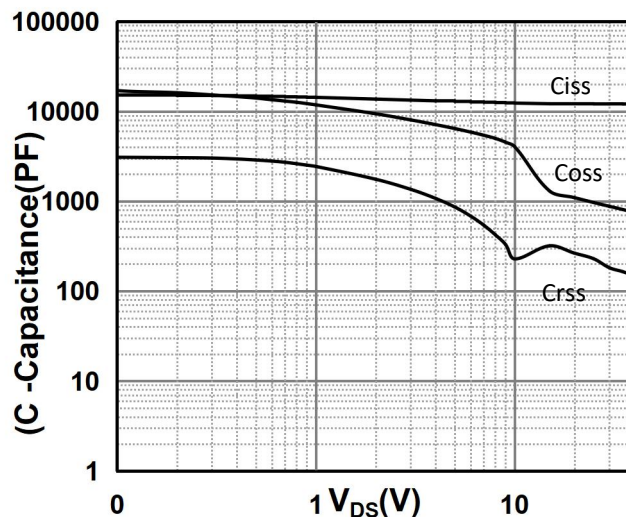


Fig 5: Power Dissipation

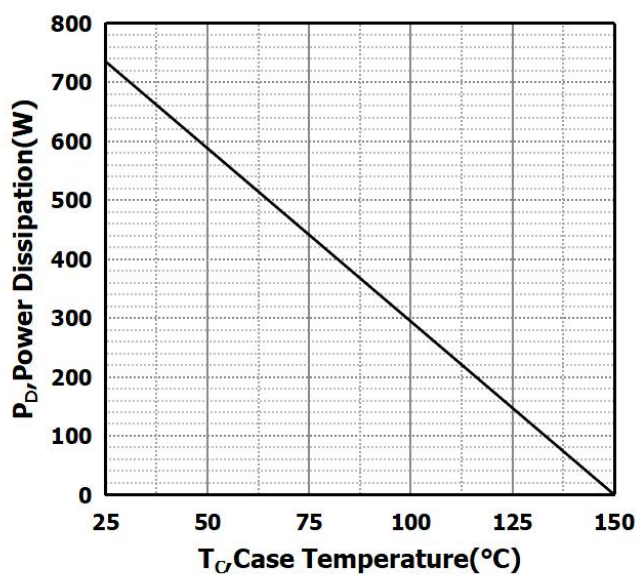


Fig 6: Drain Current Derating

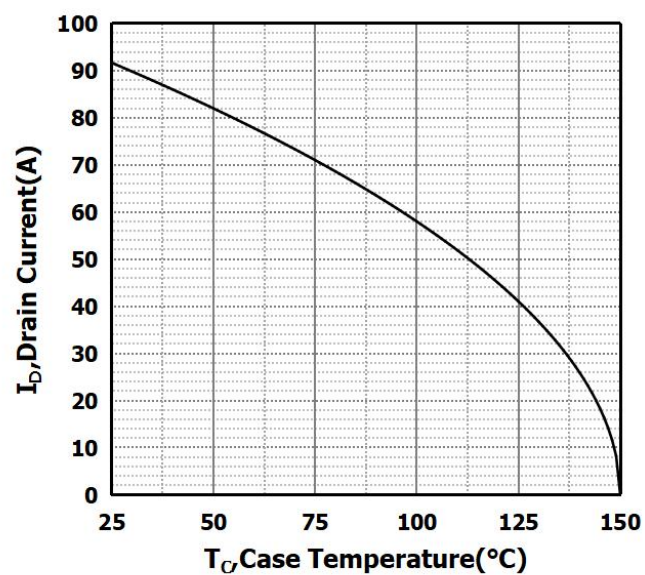
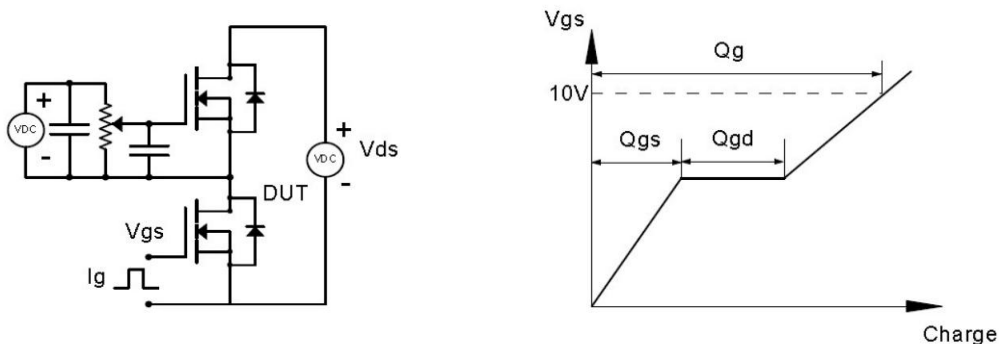


Fig 7: Maximum Transient Thermal Resistance

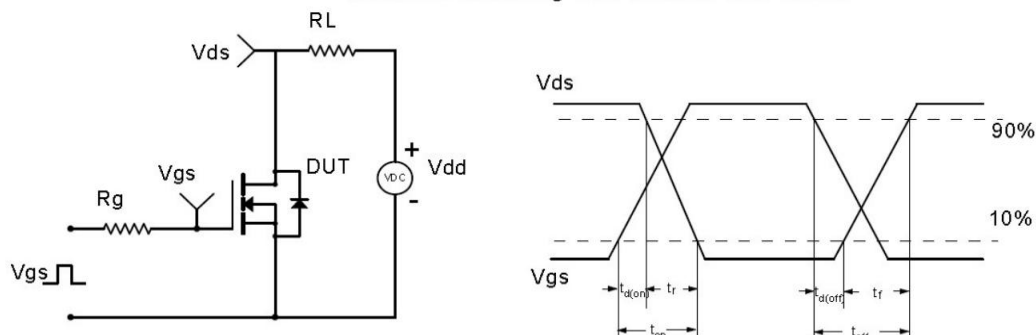


Test Circuit & Waveform

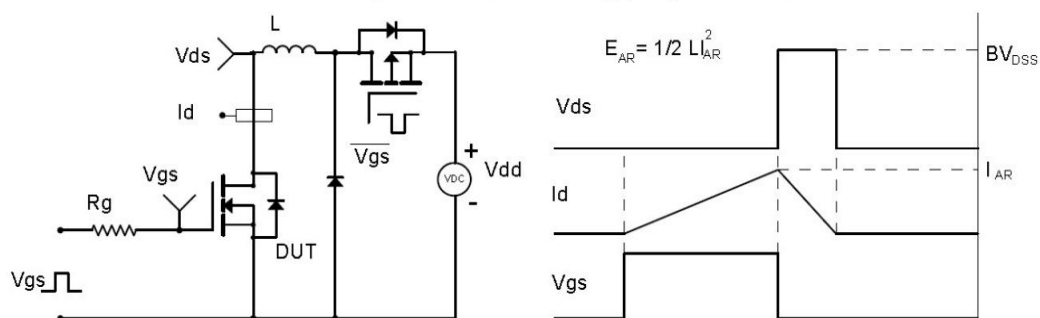
Gate Charge Test Circuit & Waveform



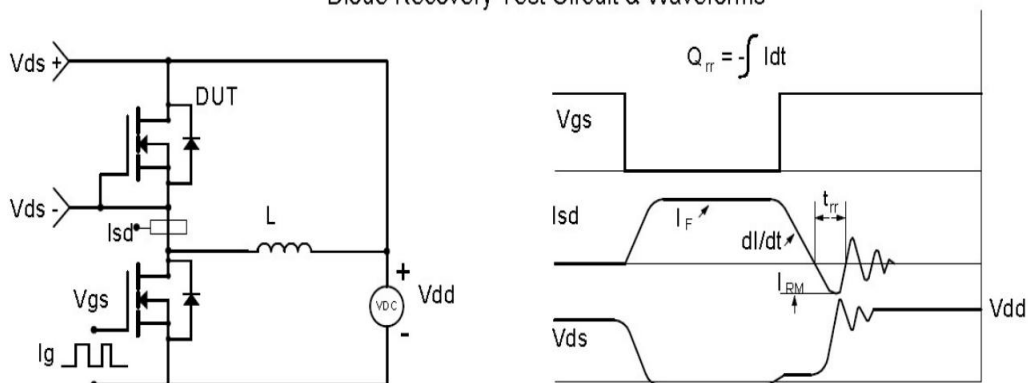
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



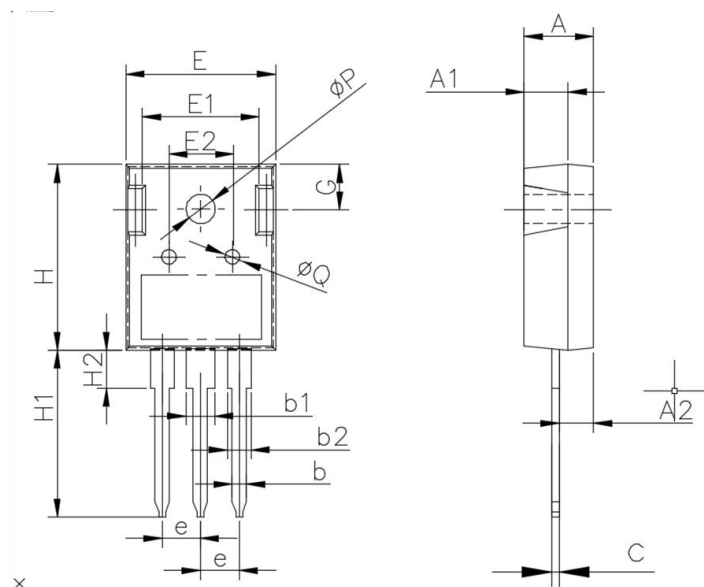
Diode Recovery Test Circuit & Waveforms



Package Information

TO-247H PACKAGE

基本尺寸



Symbol	单位 mm		
	Min	Nom	Max
A	4.80	5.00	5.20
A1	2.80	3.00	3.20
A2	2.20	2.40	2.60
b	1.05	1.20	1.35
b1	2.80	3.00	3.20
b2	1.80	2.00	2.20
c	0.50	0.60	0.70
e	5.35	5.45	5.75
E	15.6	15.80	16.0
E1	12.3	12.50	12.7
E2	6.00	6.20	6.40
H	20.8	21.0	21.2
H1	19.5	20.0	20.5
H2	3.70	4.00	4.30
G	5.70	5.90	6.10
ϕP	3.30	3.50	3.70
ϕQ	2.30	2.50	2.70

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-Headquarters

WuXi Thunder Microelectronics Incorporated Limited

Building E1-9, No.200 LingHu Road, XinWu district,WuXi,China 214135

Tel:+86-510-85160109

Fax:+86-510-85160109